

ON Semiconductor®

FDS4675-F085 40V P-Channel PowerTrench[®] MOSFET

General Description

This P-Channel MOSFET is a rugged gate version of ON Semiconductor's advanced Power Tranch process. It has been optimized for power management applications requiring a wide range of gave drive voltage ratings (4.5 V - 20 V).

Applications

- **Powermanagement**
- . Load switch
- **Battery protection**



Features

-11 A, -40 V $\ R_{DS(ON)}$ = 0.013 Ω @ V_{GS} = -10 V $R_{DS(ON)} = 0.017 \Omega @ V_{GS} = -4.5 V$

- Fast switching speed
- High performance trench technology for extremely low R_{DS(ON)}

4

3

2

1

- High power and current handling capability
- Qualified to AEC Q101

5

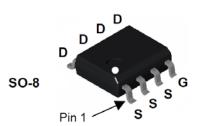
6

7

8

12mm

RoHS Compliant



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

FDS4675-F085

Symbol		Parame	ter	Ratings		Units	
V _{DSS}	Drain-Sourc	e Voltage		-40	-40		
V _{GSS}	Gate-Source	e Voltage		-	±20		
I _D	Drain Current		Continuous	-11 ^(Note 1a)		Α	
			Pulsed	-50		А	
P _D	Power Dissipation for Single Operation			2.4 (steady st	2.4 (steady state) (Note 1a)		
				1.4 ^{(Not}	1.4 ^(Note 1b)		
				1.2 ^{(Not}	1.2 ^(Note 1c)		
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +	-55 to +150		
Thermal	Characte	ristics					
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient			62.5 (steady state), \$	62.5 (steady state), 50 (10 sec) ^(Note 1a)		
$R_{ heta JA}$	Thermal Re	sistance, Junction to Am	125 ^{(Not}	125 ^(Note 1c)			
$R_{ ext{ heta}JC}$	Thermal Re	sistance, Junction to Ca	25 ^{(Not}	25 ^(Note 1)			
ackage	Marking	and Ordering In	nformation	L			
Device Marking		Device	Reel Size	Tape width Quant		/	

13"

FDS4675

2500 units



FDS4675-F085
— 40V
P-ChannelTrench [®]
MOSFET

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Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
ff Characterist	lics					
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = -250 \mu A$	-40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 µA, Referenced to 25°C		-34		mV/
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -32 V_{,} V_{GS} = 0 V$			-1	μA
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 20 V, V_{DS} = 0 V$			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20 V, V_{DS} = 0 V$			-100	n/
n Characterist	tics (Note 2)					<u> </u>
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1	-1.4	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, Referenced to $25^{\circ}C$		4.6		mV,
		V_{GS} = -10 V, I_{D} = -11 A		10	13	
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} = -4.5 V, I _D = -9.5 A		13	17	m
		V_{GS} = -10 V, I_D = -11 A, T_J = 125 °C		15	21	1
g _{FS}	Forward Transconductance	$V_{DS} = -5 V, I_{D} = -11 A$		44		S
ynamic Charac	cteristics					
CISS	Input Capacitance			4350		pl
C _{oss}	Output Capacitance	$V_{\text{DS}} = -20 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1 \text{ MHz}$		622		р
C_{RSS}	Reverse Transfer Capacitance			290		р
witching Chara	acteristics ^(Note 2)	•				
t _{d(on)}	Tum-On Delay Time			40	64	n
tr	Turn-On Rise Time	$V_{DD} = -20 V, I_D = -1 A$		49	79	n
$t_{d(off)}$	Tum-Off Delay Time	V_{GS} = -4.5 V, R_{GEN} = 6 Ω		100	160	n
t _f	Turn-Off Fall Time			60	96	n
Qg	Total Gate Charge			40	56	n
Q_{gs}	Gate-Source Charge	V_{DS} = -20 V, I_{D} = -11 A, V_{GS} = -4.5 V		11		n
Q_{gd}	Gate-Drain Charge			13		n
rain-Source Di	ode Characteristics and Maximum Ra	tings				
ls	Maximum Continuous Drain-Source Diode Forward Current				-2.1	A
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ A}, \text{ I}_{S} = -2.1 \text{ A}^{(Note \ 2)}$		-0.7	-1.2	١

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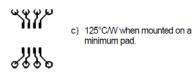
R_{0.1A} is the sum of the junction to case and case to ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0.1C} is guaranteed by design while R_{0.CA} is determined by the user's board design.



a) 50°C/W when mounted on a 1in2 pad of 2 oz copper

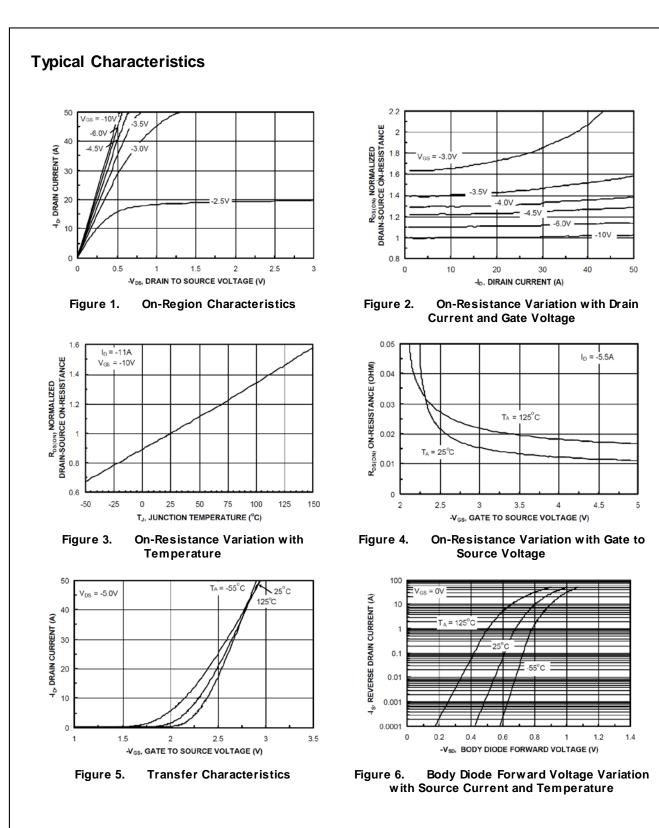


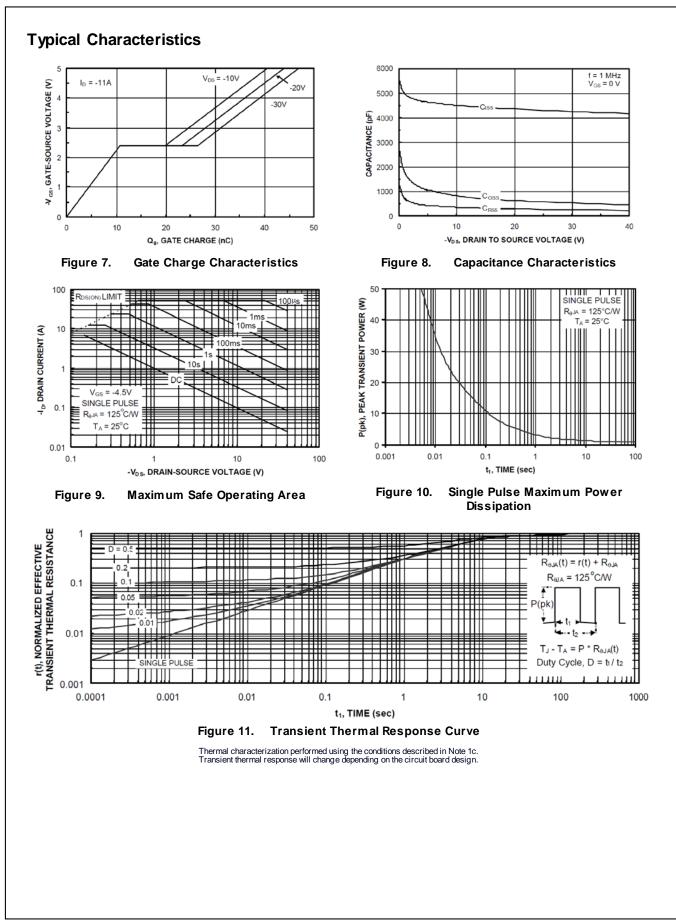
b) 105°C/W when mounted on a .04 in² pad of 2 oz copper

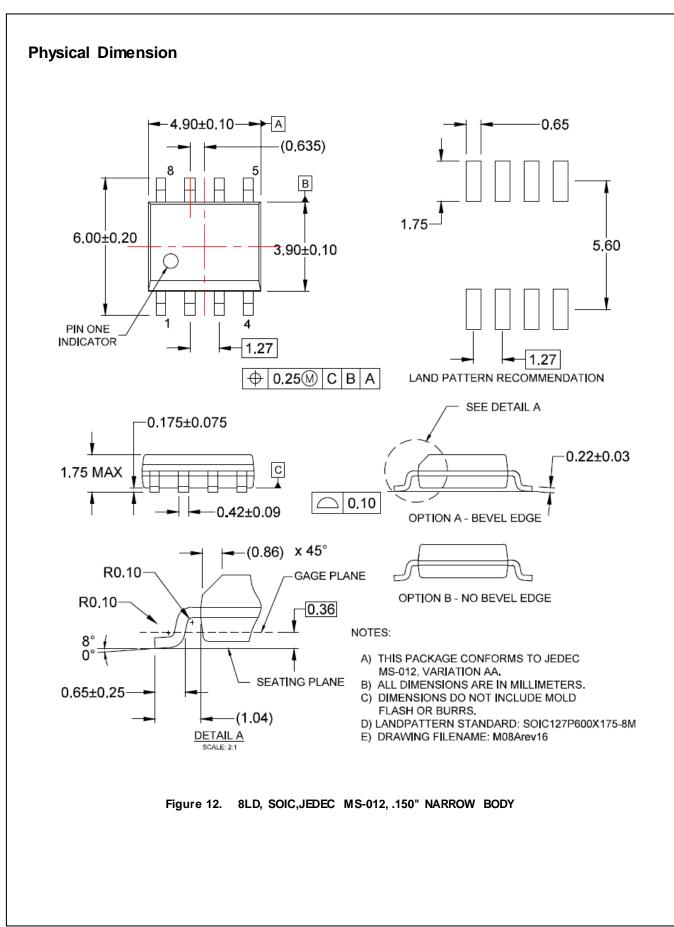


Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty Cycle < 2.0%







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